Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/690,560	NAKAHARA ET AL.	
Examiner	Art Unit	
Khanh Tran	2611	

	SEARCHED			
Class	Subclass	Date	Examiner	
375	342-343 355,362 260,364	9/20/2007	кст	
370	514			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	all cited	9/20/2007	кст
370	all cited		

SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	
	DATE	EXMR
Update EAST Searches	9/20/2007	кст